Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination
10/691,539	OBA ET AL.
Examiner	Art Unit

2861

Hai C. Pham

	SEAR	CHED	
Class	Subclass	Date	Examiner
347	236-237, 246-247	6/17/2005	НР
	1		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
		DATE	EXMR
EAST		4/28/2005	НР

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